IGBT - Field Stop, Trench 650 V, 75 A

FGH75T65UPD-F085

Description

Using Novel Field Stop Trench IGBT Technology, ON Semiconductor's new series of Field Stop Trench IGBTs offer the optimum performance for Automotive chargers, Solar Inverter, UPS and Digital Power Generator where low conduction and switching losses are essential.

Features

- Maximum Junction Temperature : $T_J = 175$ °C
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: V_{CE(sat)} = 1.65 V (Typ.) @ I_C = 75 A
- High Input Impedance
- Tightened Parameter Distribution
- AEC-Q101Qualified and PPAP Capable
- This Device is Pb-Free and is RoHS Compliant

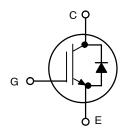
Applications

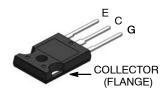
- Automotive Chargers, Converters, High Voltage Auxiliaries
- Solar Inverters, UPS, Digital Power Generator



ON Semiconductor®

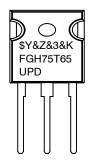
www.onsemi.com





TO-247-3LD CASE 340CK

MARKING DIAGRAM



= ON Semiconductor Logo \$Y &Z = Assembly Plant Code &3 = Numeric Date Code

&K = Lot Code

FGH75T65UPD = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS

Description	Symbol	Ratings	Unit	
Collector to Emitter Voltage		V _{CES}	650	V
Gate to Emitter Voltage		V _{GES}	±20	V
Collector Current	Tc = 25°C	I _C	150	Α
	Tc = 100°C		75	Α
Pulsed Collector Current	I _{CM} (Note 1)	225	Α	
Diode Forward Current	Tc = 25°C	I _F	75	Α
	Tc = 100°C		50	Α
Pulsed Diode Maximum Forward Current		I _{FM} (Note 1)	225	Α
Maximum Power Dissipation	Tc = 25°C	P _D	375	W
	Tc = 100°C		187	W
Short Circuit Withstand Time	Tc = 25°C	SCWT	5	μs
Operating Junction Temperature	TJ	-55 to +175	°C	
Storage Temperature Range	T _{stg}	-55 to +175	°C	
Maximum Lead Temperature for Soldering, 1/8" from C	Case for 5 Seconds	T _L	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive rating: Pulse width limited by max. junction temperature.

THERMAL CHARACTERISTICS

Parameter	Symbol	Ratings	Unit
Thermal Resistance, Junction-to-Case	R _{θJC} (IGBT) (Note 2)	0.4	°C/W
Thermal Resistance, Junction-to-Case	R ₀ JC (Diode)	0.86	°C/W
Parameter	Symbol	Тур	
Thermal Resistance, Junction-to-Ambient (PCB Mount) (Note 2)	$R_{ heta JA}$	40	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Mark	Package	Package Method	Reel Size	Tape Width	Quantity
FGH75T65UPD-F085	FGH75T65UPD	TO-247	Tube	-	-	30

ELECTRICAL CHARACTERISTICS OF THE IGBT ($T_C = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS		•				
Collector to Emitter Breakdown Voltage	BV _{CES}	V _{GE} = 0 V, I _C = 1 mA	650	_	-	V
Temperature Coefficient of Breakdown Voltage	ΔBV _{CES} / ΔΤ _J	V _{GE} = 0 V, I _C = 1 mA	-	0.65	-	V/°C
Collector Cut-Off Current	I _{CES}	V _{CE} = V _{CES} , V _{GE} = 0 V	_	-	250	μΑ
		I _{CES} at 80% * B _{VCES} , 175°C	_	-	3600	
G-E Leakage Current	I _{GES}	V _{GE} = V _{GES} , V _{CE} = 0 V	-	-	±400	nA
ON CHARACTERISTICs						
G-E Threshold Voltage	V _{GE(th)}	I_C = 75 mA, V_{CE} = V_{GE}	4.0	6.0	7.5	V
Collector to Emitter Saturation Voltage	V _{CE(sat)}	I _C = 75 A, V _{GE} = 15 V	_	1.69	2.3	V
		I _C = 75 A, V _{GE} = 15 V, T _C = 175°C	_	2.21	_	V

$\textbf{ELECTRICAL CHARACTERISTICS OF THE IGBT} \ (T_C = 25^{\circ}C \ unless \ otherwise \ noted) \ (continued)$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{ies}	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V}, f = 1 \text{ MHz}$	-	5665	_	pF
Output Capacitance	C _{oes}		-	205	-	pF
Reverse Transfer Capacitance	C _{res}		ı	100	-	pF
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(on)}	$V_{CC} = 400 \text{ V}, I_{C} = 75 \text{ A},$	-	32	48	ns
Rise Time	t _r	$R_G = 3 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25^{\circ}C$	_	43	71	ns
Turn-Off Delay Time	t _{d(off)}		_	166	216	ns
Fall Time	t _f		_	24	33	ns
Turn-On Switching Loss	E _{on}		-	2.85	4.80	mJ
Turn-Off Switching Loss	E _{off}		-	1.20	1.60	mJ
Total Switching Loss	E _{ts}]	_	4.05	5.30	mJ
Turn-On Delay Time	t _{d(on)}	V _{CC} = 400 V, I _C = 75 A,	-	30	-	ns
Rise Time	t _r	$R_G = 3 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 175^{\circ}C$	-	57	-	ns
Turn-Off Delay Time	t _{d(off)}		-	176	-	ns
Fall Time	t _f		-	21	-	ns
Turn-On Switching Loss	E _{on}		-	4.45	-	mJ
Turn-Off Switching Loss	E _{off}		-	1.60	-	mJ
Total Switching Loss	E _{ts}		-	6.05	-	mJ
Short Circuit Withstand Time	Tsc	V_{GE} = 15 V, $V_{CC} \le$ 400V, R_{G} = 10 Ω	5	-	-	μs
Total Gate Charge	Qg	V _{CE} = 400 V, I _C = 75 A, V _{GE} = 15 V	-	385	578	nC
Gate to Emitter Charge	Q _{ge}		-	45	68	nC
Gate to Collector Charge	Q _{gc}]	-	210	315	nC

ELECTRICAL CHARACTERISTICS OF THE DIODE ($T_J = 25^{\circ}C$ unless otherwise noted)

Parametr	Symbol	Test Conditions		Min	Тур	Max	Unit
Diode Forward Voltage	V_{FM}	I _F = 50 A	T _C = 25°C	_	2.1	2.6	V
			T _C = 175°C	_	1.7	_	
Reverse Recovery Energy	E _{rec}	$I_F = 50 \text{ A}, dI_F/dt = 200 \text{ A}/\mu\text{s}$	T _C = 175°C	_	40	_	μJ
Diode Reverse Recovery Time	t _{rr}		T _C = 25°C	_	43	85	ns
			T _C = 175°C	_	162	_	
Diode Reverse Recovery Charge	Q _{rr}		T _C = 25°C	_	83	170	nC
			T _C = 175°C	_	805	_	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. R0jc for TO-247: according to Mil standard 883-1012 test method. R0ja for TO-247: according to JESD51-2, test method environmental

Rθjc for TO-247: according to Mil standard 883-1012 test method. Rθja for TO-247: according to JESD51-2, test method environmental
condition and JESD51-10, test boards for through hole perimeter leaded package thermal measurements. JESD51-3: Low Effective
Thermal Conductivity Test Board for Leaded Surface Mount Package.

TYPICAL PERFORMANCE CHARACTERISTICS

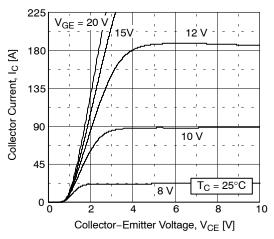


Figure 1. Typical Output Characteristics

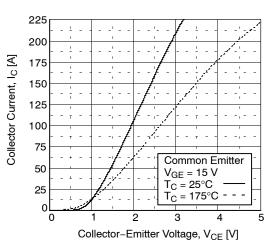


Figure 3. Typical Saturation Voltage Characteristics

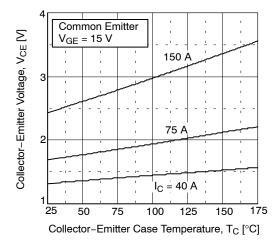


Figure 5. Saturation Voltage vs. Case Temperature at Variant Current Level

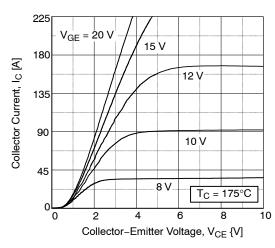


Figure 2. Typical Output Characteristics

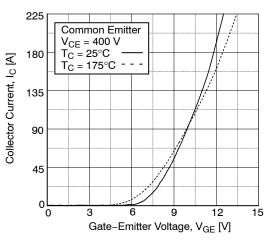


Figure 4. Transfer Characteristics

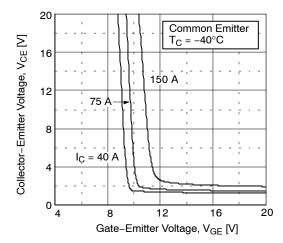


Figure 6. Saturation Voltage vs. V_{GE}

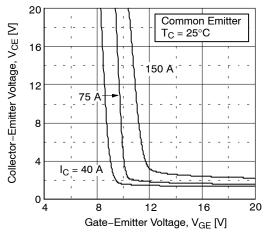


Figure 7. Saturation Voltage vs. V_{GE}

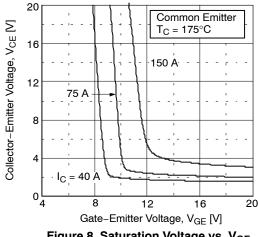


Figure 8. Saturation Voltage vs. V_{GE}

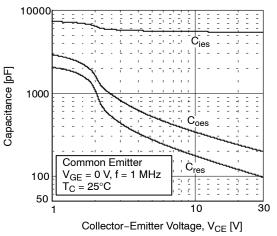


Figure 9. Capacitance Characteristics

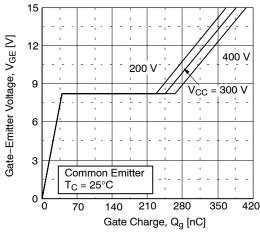


Figure 10. Gate Charge Characteristics

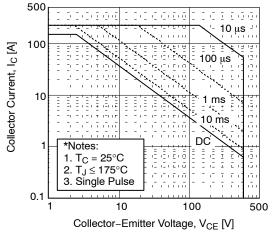


Figure 11. SOA Characteristics

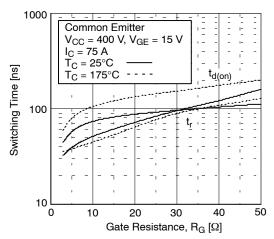


Figure 12. Turn-on Characteristics vs. Gate Resistance

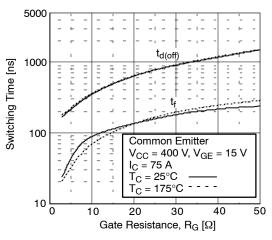


Figure 13. Turn-off Characteristics vs. Gate Resistance

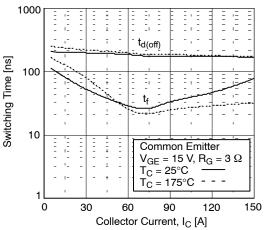


Figure 15. Turn-off Characteristics vs. Collector Current

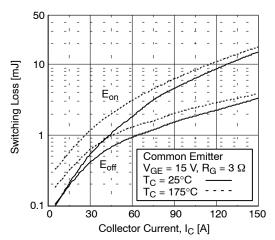


Figure 17. Switching Loss vs. Collector Current

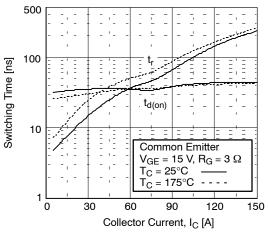


Figure 14. Turn-on Characteristics vs. Collector Current

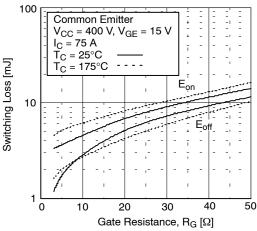


Figure 16. Switching Loss vs. Gate Resistance

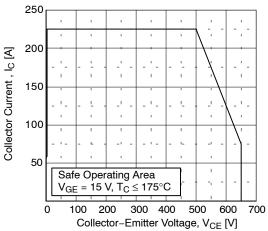


Figure 18. Turn-off Switching SOA
Characteristics

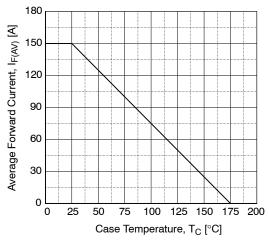


Figure 19. Current Derating

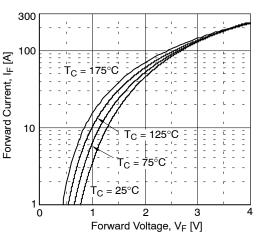


Figure 21. Forward Characteristics

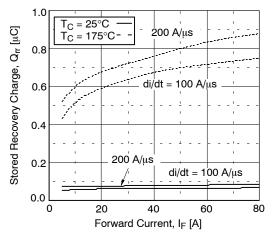


Figure 23. Stored Charge

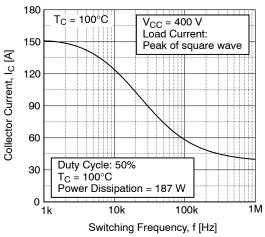


Figure 20. Load Current vs. Frequence

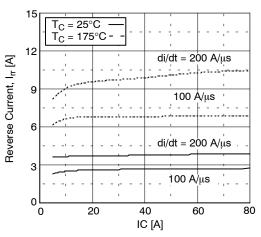


Figure 22. Reverse Recovery Time

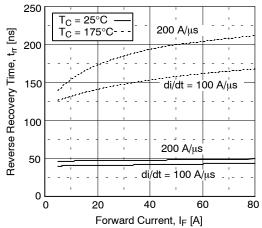


Figure 24. Reverse Recovery Time

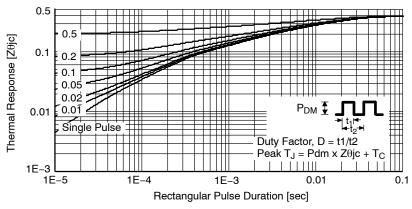


Figure 25. Transient Thermal Impedance of IGBT

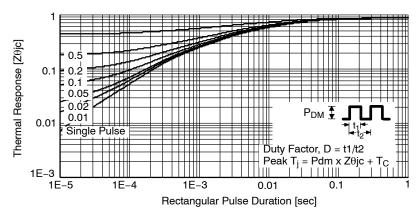
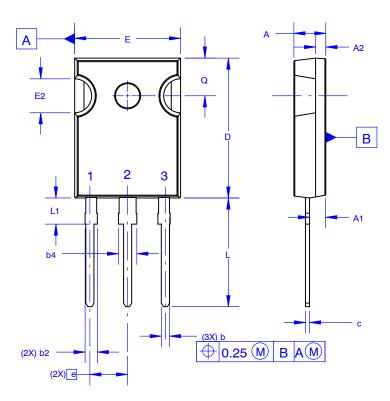


Figure 26. Transient Thermal Impedance of Diode

TO-247-3LD SHORT LEAD

CASE 340CK ISSUE A





- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

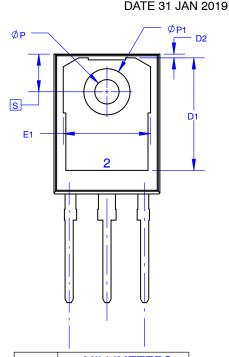
A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



DIM	MILLIMETERS				
DIIVI	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
A 1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D	20.32	20.57	20.82		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
E	15.37	15.62	15.87		
E1	12.81	?	~		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	15.75	16.00	16.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
ØP1	6.60	6.80	7.00		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		

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DESCRIPTION:	TO-247-3LD SHORT LEAD	TO-247-3LD SHORT LEAD			

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